

Search Notes

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Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

YAMAKAWA, HIROMITSU

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
347	241-244, 256-258	2/10/2007	HP
359	204-207	2/10/2007	HP
396	548	2/10/2007	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	2/10/2007	HP